Amendments to the Claims

The listing of claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims:

1. (Original) A probe block assembly for probing a device under test (DUT), comprising:

a plurality of independent probe blocks each having a set of probes and/or receptacles that mate to a respective mating set of DUT receptacles and/or probes on said DUT;

a probe block frame which floatably holds said plurality of independent probe blocks to allow each said independent probe block to independently float within said probe block frame relative to a predetermined position within said frame.

2. (Original) A probe block assembly in accordance with claim 1, wherein:

said plurality of Independent probe blocks are positioned such that each of said respective set of probes and/or receptacles of said respective plurality of independent probe blocks are aligned parallel to a like axis of probing.

- 3. (Original) A probe block assembly in accordance with claim 2, wherein said plurality of independent probe blocks are positioned side-by-side within said frame such that each of said respective set of probes and/or receptacles of said respective plurality of independent probe blocks are aligned parallel to one another and to said axis of probing.
- 4. (Original) A probe block assembly in accordance with claim 1, comprising:

an actuator attached to said probe block frame to controllably move

said frame to Insert and/or remove said sets of probes and/or receptacles of each of said plurality of independent probe blocks to and/or from said respective mating set of DUT receptacles and/or probes on said DUT.

- 5. (Original) A probe block assembly in accordance with claim 1, wherein at least one of said plurality of independent probe blocks comprises self-centering capability that allows said independent probe block to align to said respective mating set of DUT receptacles and/or probes on said DUT.
- 6. (Original) A probe block assembly in accordance with claim 5, wherein said self-centering capability comprises at least one pair of coaxially aligned springs positioned perpendicular to said axis of probing on opposite sides of said independent probe block.
- 7. (Withdrawn) A method for probing a plurality of sets of receptacles and/or probes of a device under test (DUT), said plurality of receptacles and/or probes requiring probing parallel to a like probing axis, said method comprising:

independently floating a probe block for each of said plurality of sets of DUT receptacles and/or probes of said DUT within a single probe block frame, each said independently floating probe block having a respective set of probe block probes and/or receptacles that mate to a corresponding set of said plurality of sets of receptacles and/or probes of said DUT;

aligning each said independently floating probe block within said single probe block frame to its corresponding set of said plurality of sets of receptacles and/or probes of said DUT; and

actuating said single probe block frame along said probing axis to respectively engage each said respective set of probe block probes and/or receptacles to its corresponding set of DUT receptacles and/or probes.

8. (Withdrawn) A method in accordance with claim 7, wherein:

said actuating step is performed with a single actuation motion.

9. (Withdrawn) A method for assembling a probe block assembly for probing a device under test (DUT), said method comprising:

obtaining a plurality of independent probe blocks each having a set of probes and/or receptacles that mate to a respective mating set of DUT receptacles and/or probes on said DUT; and

independently floating said plurality of independent probe blocks within a single probe block frame relative to a predetermined position within said frame.

10. (Withdrawn) A method in accordance with claim 9, wherein said step for independently floating said plurality of independent probe blocks within said single probe block frame comprises:

positioning each said plurality of independent probe blocks relative to said predetermined position with said single probe block frame such that when said probe block frame is substantially aligned in a predetermined position relative a device under test, each said respective set of probe block probes and/or receptacles substantially aligns to its respective mating set of DUT receptacles and/or probes on said DUT.

- 11. (New) A probe block assembly in accordance with claim 5, wherein at least one of said plurality of independent probe blocks comprises at least one spring receptacle for holding a respective coil spring.
- 12. (New) A probe block assembly in accordance with claim 11, further comprising:

at least one coil spring seated in a respective one of said at least one spring receptable.

13. (New) A probe block assembly in accordance with claim 3,

comprising:

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an actuator attached to said probe block frame to controllably move said frame to insert and/or remove said sets of probes and/or receptacles of each of said plurality of independent probe blocks to and/or from said respective mating set of DUT receptacles and/or probes on said DUT.

- 14. (New) A probe block assembly in accordance with claim 13, wherein at least one of said plurality of independent probe blocks comprises self-centering capability that allows said independent probe block to align to said respective mating set of DUT receptacles and/or probes on said DUT.
- 15. (New) A probe block assembly in accordance with claim 14, wherein said self-centering capability comprises at least one pair of coaxially aligned springs positioned perpendicular to said axis of probing on opposite sides of said independent probe block.
- 16. (New) A probe block assembly in accordance with claim 3, wherein at least one of said plurality of independent probe blocks comprises self-centering capability that allows said independent probe block to align to said respective mating set of DUT receptacles and/or probes on said DUT.
- 17. (New) A probe block assembly in accordance with claim 16, wherein said self-centering capability comprises at least one pair of coaxially aligned springs positioned perpendicular to said axis of probing on opposite sides of said independent probe block.